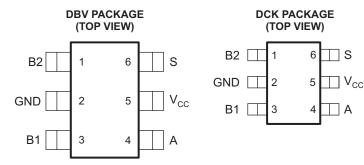
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SINGLE-POLE DOUBLE-THROW ANALOG SWITCH

FEATURES

- Qualified for Automotive Applications
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- 1.65-V to 5.5-V V_{CC} Operation
- Useful for Both Analog and Digital Applications
- Specified Break-Before-Make Switching

- Rail-to-Rail Signal Handling
- . High Degree of Linearity
- High Speed, Typically 0.5 ns (V_{CC} = 3 V, C_L = 50 pF)
- Low On-State Resistance, Typically \approx 6 Ω (V_{CC} = 4.5 V)
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II



See mechanical drawings for dimensions.

DESCRIPTION/ORDERING INFORMATION

This single-pole double-throw (SPDT) analog switch is designed for 1.65-V to 5.5-V V_{CC} operation.

The SN74LVC1G3157 can handle both analog and digital signals. The device permits signals with amplitudes of up to V_{CC} (peak) to be transmitted in either direction.

Applications include signal gating, chopping, modulation or demodulation (modem), and signal multiplexing for analog-to-digital and digital-to-analog conversion systems.

ORDERING INFORMATION⁽¹⁾

| T _A | PACKAGE | (2) | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
|----------------|--------------------|--------------|-----------------------|------------------|
| –40°C to 125°C | SOT (SOT-23) – DBV | Reel of 3000 | 1P1G3157QDBVRQ1 | CC50 |
| -40 C to 125 C | SOT (SC-70) - DCK | Reel of 3000 | 1P1G3157QDCKRQ1 | C50 |

⁽¹⁾ For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

FUNCTION TABLE

| CONTROL INPUTS | ON CHANNEL |
|----------------|---------------|
| L | B1 |
| Н | B2 |

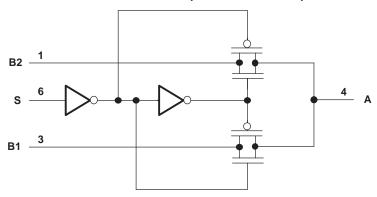


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

⁽²⁾ Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



LOGIC DIAGRAM (POSITIVE LOGIC)



Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

| | | | MIN | MAX | UNIT |
|------------------|---|--|------|-----------------------|-------|
| V_{CC} | Supply voltage range (2) | -0.5 | 6.5 | V | |
| V _{IN} | Control input voltage range (2)(3) | | -0.5 | 6.5 | V |
| V _{I/O} | Switch I/O voltage range (2)(3)(4)(5) | | -0.5 | V _{CC} + 0.5 | V |
| I _{IK} | Control input clamp current | V _{IN} < 0 | | -50 | mA |
| I _{IOK} | I/O port diode current | V _{I/O} < 0 | | -50 | mA |
| I _{I/O} | On-state switch current | $V_{I/O} = 0 \text{ to } V_{CC}^{(6)}$ | | ±128 | mA |
| | Continuous current through V _{CC} or GND | | | ±100 | mA |
| 0 | Decke so thermal impedance (7) | DBV package | | 165 | °C/W |
| θ_{JA} | Package thermal impedance (7) | DCK package | | 258 | -C/VV |
| T _{stg} | Storage temperature range | | -65 | 150 | °C |

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

All voltages are with respect to ground, unless otherwise specified.

The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

This value is limited to 5.5 V maximum.

 $V_{I},\,V_{O},\,V_{A},\,$ and V_{Bn} are used to denote specific conditions for $V_{I/O}.$ (5)

 I_{\parallel} , I_{\odot} , I_{A} , and I_{Bn} are used to denote specific conditions for $I_{\parallel/\odot}$. The package thermal impedance is calculated in accordance with JESD 51-7.



Recommended Operating Conditions⁽¹⁾

| | | | MIN | MAX | UNIT |
|------------------|---|--|----------------------|---------------------------|------|
| V _{CC} | | | 1.65 | 5.5 | V |
| V _{I/O} | | | 0 | V_{CC} | V |
| V _{IN} | | | 0 | 5.5 | V |
| V | High level input voltage, control input | $V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$ | $V_{CC} \times 0.75$ | | V |
| V _{IH} | V _{IH} High-level input voltage, control input | $V_{CC} = 2.3 \text{ V to } 5.5 \text{ V}$ | $V_{CC} \times 0.7$ | | V |
| V | Low level input veltage, central input | V _{CC} = 1.65 V to 1.95 V | | $V_{CC} \times 0.25$ | V |
| V_{IL} | Low-level input voltage, control input | $V_{CC} = 2.3 \text{ V to } 5.5 \text{ V}$ | | $V_{\text{CC}}\times 0.3$ | V |
| | | $V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$ | | 20 | |
| A+/A., | Input transition via a /fall time | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$ | | 20 | ns/V |
| Δt/Δv | Input transition rise/fall time | $V_{CC} = 3 \text{ V to } 3.6 \text{ V}$ | | 10 | HS/V |
| | | V _{CC} = 4.5 V to 5.5 V | | 10 | |
| T _A | | | -40 | 125 | °C |

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | | TES | V _{CC} | MIN TYP ⁽¹⁾ | MAX | UNIT | | |
|---------------------------------|---|------------------|---|--|------------------------|----------|-------|---------------------|----|
| | | | | $V_I = 0 V$, | $I_O = 4 \text{ mA}$ | 1.65 V | 11 | 20 | |
| | | | | $V_I = 1.65 V$, | $I_O = -4 \text{ mA}$ | 1.05 V | 15 | 50 | |
| | | | | $V_I = 0 V$, | $I_O = 8 \text{ mA}$ | 2.3 V | 8 | 12 | i |
| | | | | $V_I = 2.3 V$, | $I_O = -8 \text{ mA}$ | 2.3 V | 11 | 30 | |
| r _{on} | On-state switch resistance | e ⁽²⁾ | See Figure 1 and Figure 2 | $V_I = 0 V$, | $I_O = 24 \text{ mA}$ | 3 V | 7 | 9.5 | Ω |
| | | | Januari igana L | $V_I = 3 V$, | $I_O = -24 \text{ mA}$ | 3 V | 9 | 20 | |
| | | | | $V_I = 0 V$, | $I_O = 30 \text{ mA}$ | | 6 | 7.5 | |
| | | | | $V_1 = 2.4 V$, | $I_O = -30 \text{ mA}$ | 4.5 V | 7 | 12 | |
| | | | | $V_1 = 4.5$, | $I_O = -30 \text{ mA}$ | | 7 | 15 | |
| | | | | | $I_A = -4 \text{ mA}$ | 1.65 V | | 140 | |
| _ | On-state switch resistance | e | $0 \le V_{Bn} \le V_{CC}$ | | $I_A = -8 \text{ mA}$ | 2.3 V | | 45 | Ω |
| r _{range} | over signal range (2)(3) | | (see Figure 1 and F | igure 2) | $I_A = -24 \text{ mA}$ | 3 V | | 18 | 12 |
| | | | | | $I_A = -30 \text{ mA}$ | 4.5 V | | 10 | |
| | | | | V _{Bn} = 1.15 V, | $I_A = -4 \text{ mA}$ | 1.65 V | 0.5 | | |
| ۸۰ | Difference in on-state resistance between | | | $V_{Bn} = 1.6 V,$ | $I_A = -8 \text{ mA}$ | 2.3 V | 0.1 | | Ω |
| Δr_{on} | switches ^{(2) (4) (5)} | | See Figure 1 | $V_{Bn} = 2.1 V$, | $I_A = -24 \text{ mA}$ | 3 V | 0.1 | | |
| | | | | $V_{Bn} = 3.15 \text{ V},$ | $I_A = -30 \text{ mA}$ | 4.5 V | 0.1 | | |
| | | | I _A = -4 mA | | | 1.65 V | 110 | | |
| _ | On-state resistance | | $0 \le V_{Bn} \le V_{CC}$ $I_A = -8 \text{ mA}$ $I_A = -24 \text{ mA}$ $I_A = -30 \text{ mA}$ | | | 2.3 V | 26 | | Ω |
| r _{on(flat)} | flatness (2)(4)(6) | | | | | 3 V | 9 | | |
| | | | | | | 4.5 V | 4 | | |
| I _{off} ⁽⁷⁾ | Off state quitab leakage | ou we ont | 0 < \/ \/ < \/ \/ \(\) | o Figure 2) | | 1.65 V | | ±1 | ^ |
| loff` ′ | Off-state switch leakage | current | $0 \le V_I, V_O \le V_{CC}$ (se | ee rigure 3) | | to 5.5 V | ±0.05 | ±1 ⁽¹⁾ | μΑ |
| | On state quitab leakage | ourront | V – V – or CND V | _ Open (eee F | iguro 4) | 5.5 V | | ±1 | ^ |
| I _{S(on)} | On-state switch leakage | current | V _I = V _{CC} OI GIVD, V | $V_I = V_{CC}$ or GND, $V_O = Open$ (see Figure 4) | | | | ±0.1 ⁽¹⁾ | μΑ |
| | Control input ourrent | | 061/61/ | | | 0 V | | ±1 | ^ |
| I _{IN} | Control input current | | $0 \le V_{IN} \le V_{CC}$ | | | to 5.5 V | ±0.05 | ±1 ⁽¹⁾ | μΑ |
| I _{CC} | Supply current | | $V_{IN} = V_{CC}$ or GND | 5.5 V | 1 | 10 | μΑ | | |
| ΔI_{CC} | Supply-current change | | $V_{IN} = V_{CC} - 0.6 \text{ V}$ | 5.5 V | _ | 500 | μΑ | | |
| C _{in} | Control input capacitance | s | | | | 5 V | 2.7 | | pF |
| C _{io(off)} | Switch input/output capacitance | Bn | | | | 5 V | 5.2 | | pF |
| C | Switch input/output | Bn | | | | 5.V | 17.3 | | nE |
| C _{io(on)} | capacitance | Α | | | | 5 V | 17.3 | | pF |

⁽¹⁾ $T_A = 25^{\circ}C$

⁽²⁾ Measured by the voltage drop between I/O pins at the indicated current through the switch. On-state resistance is determined by the lower of the voltages on the two (A or B) ports.

Specified by design

 ⁽⁴⁾ Δr_{on} = r_{on(max)} - r_{on(min)} measured at identical V_{CC}, temperature, and voltage levels
 (5) This parameter is characterized, but not tested in production.

Flatness is defined as the difference between the maximum and minimum values of on-state resistance over the specified range of (6)

⁽⁷⁾ I_{off} is the same as $I_{\text{S(off)}}$ (off-state switch leakage current).



Analog Switch Characteristics

 $T_A = 25^{\circ}C$

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | TEST CONDITIONS | V _{CC} | TYP | UNIT |
|-----------------------------------|-----------------|----------------|---|-----------------|-------|-------|
| | | | | 1.65 V | 300 | |
| Frequency response | A or Bn | Bn or A | $R_L = 50 \Omega$, | 2.3 V | 300 | MHz |
| (switch on) ⁽¹⁾ | A OI BII | DII OI A | f _{in} = sine wave (see Figure 6) | 3 V | 300 | IVITZ |
| | | | | 4.5 V | 300 | |
| | | | | 1.65 V | -54 | |
| Crosstalk | D4 D0 | B2 or B1 | $R_L = 50 \Omega$, | 2.3 V | -54 | dB |
| (between switches) ⁽²⁾ | B1 or B2 | | f _{in} = 10 MHz (sine wave) (see Figure 7) | 3 V | -54 | |
| | | | | 4.5 V | -54 | |
| | | Bn or A | | 1.65 V | -57 | dB |
| Feedthrough attenuation | A or Bn | | $C_L = 5 \text{ pF}, R_L = 50 \Omega,$ | 2.3 V | -57 | |
| (switch off) (2) | | | f _{in} = 10 MHz (sine wave) (see Figure 8) | 3 V | -57 | |
| | | | | 4.5 V | -57 | |
| Charac inication (3) | | ^ | $C_1 = 0.1 \text{ nF}, R_1 = 1 \text{ M}\Omega$ | 3.3 V | 3 | -0 |
| Charge injection (3) | S | Α | (see Figure 9) | 5 V | 7 | pC |
| Total harmonic distortion | | | V 05V= D 0000 | 1.65 V | 0.1 | % |
| | A or Bn | Bn or A | $V_I = 0.5 \text{ Vp-p}, R_L = 600 \Omega,$ $f_{in} = 600 \text{ Hz to } 20 \text{ kHz}$ | 2.3 V | 0.025 | |
| | | | (sine wave) | 3 V | 0.015 | |
| | | | (see Figure 10) | 4.5 V | 0.01 | |

⁽¹⁾ Adjust f_{in} voltage to obtain 0 dBm at output. Increase f_{in} frequency until dB meter reads -3 dB.

Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 5 and Figure 11)

| PARAMETER | FROM | TO (OUTPUT) | V _{CC} = ± 0.1 | 1.8 V 5 V | V _{CC} = : ± 0.2 | | V _{CC} = ± 0.3 | | V _{CC} = ± 0.5 | 5 V 5 V | UNIT |
|--------------------------------|---------|-------------|-------------------------|--------------|------------------------------|-----|-------------------------|-----|-------------------------|------------|------|
| | (INPUT) | (OUTPUT) | MIN | MAX | MIN | MAX | MIN | MAX | MIN | MAX | |
| t _{pd} ⁽¹⁾ | A or Bn | Bn or A | | 2 | | 1.2 | | 0.8 | | 0.3 | ns |
| t _{en} ⁽²⁾ | | Do | 7 | 24 | 3.5 | 14 | 2.5 | 7.6 | 1.7 | 5.7 | |
| t _{dis} (3) | S | Bn | 3 | 13 | 2 | 7.5 | 1.5 | 5.3 | 0.8 | 3.8 | ns |
| t _{B-M} (4) | | | 0.5 | | 0.5 | | 0.5 | | 0.5 | | ns |

⁽¹⁾ t_{pd} is the slower of t_{PLH} or t_{PHL}. Propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance when driven by an ideal voltage source (zero output impedance).

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⁽²⁾ Adjust fin voltage to obtain 0 dBm at input.

⁽³⁾ Specified by design

⁽²⁾ t_{en} is the slower of t_{PZL} or t_{PZH}.

⁽³⁾ t_{dis} is the slower of t_{PLZ} or t_{PHZ} .

⁽⁴⁾ Specified by design



PARAMETER MEASUREMENT INFORMATION

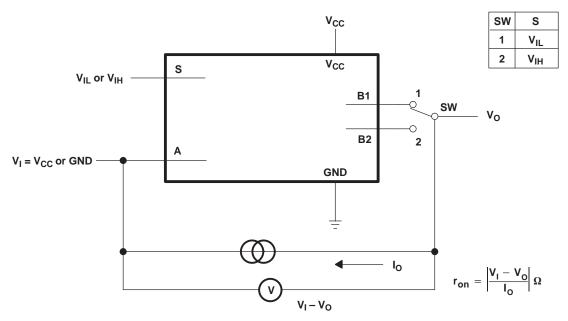


Figure 1. On-State Resistance Test Circuit

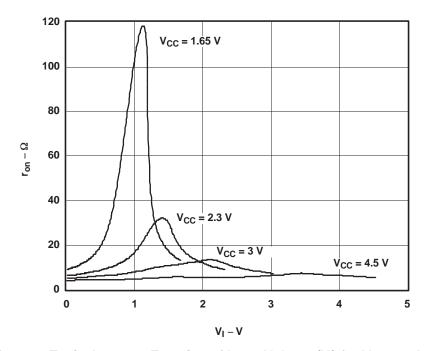
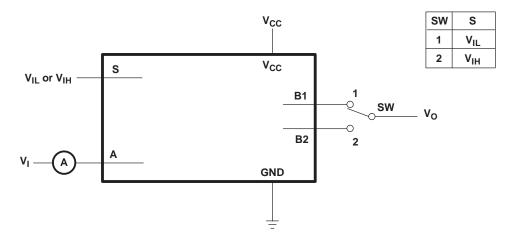


Figure 2. Typical r_{on} as a Function of Input Voltage (V_I) for $V_{I} = 0$ to V_{CC}





Condition 1: $V_I = GND$, $V_O = V_{CC}$ Condition 2: $V_I = V_{CC}$, $V_O = GND$

Figure 3. Off-State Switch Leakage-Current Test Circuit

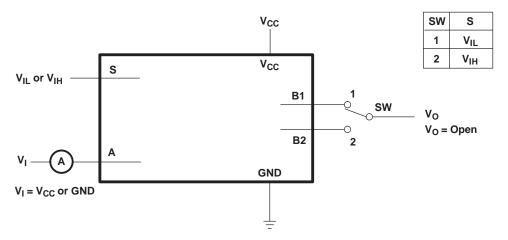
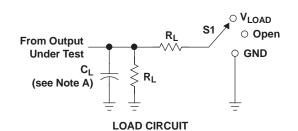


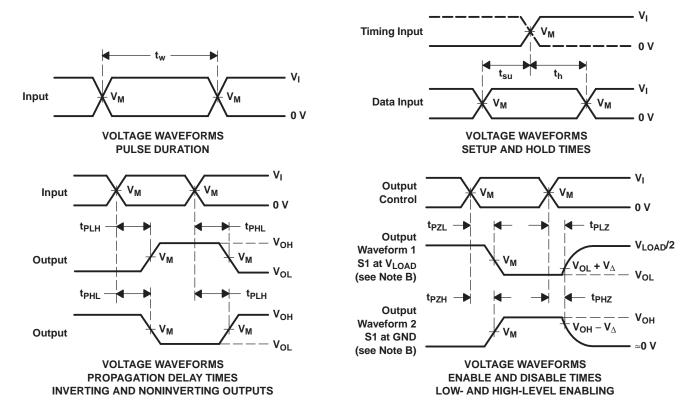
Figure 4. On-State Switch Leakage-Current Test Circuit





| TEST | S1 |
|------------------------------------|------------|
| t _{PLH} /t _{PHL} | Open |
| t _{PLZ} /t _{PZL} | V_{LOAD} |
| t _{PHZ} /t _{PZH} | GND |

| V | INPUTS | | V | V | • | Б | V |
|--------------------|-----------------|--------------------------------|--------------------|-------------------|-------|----------------|--------------|
| V _{CC} | VI | t _r /t _f | V _M | V _{LOAD} | CL | R _L | V_{Δ} |
| 1.8 V \pm 0.15 V | V _{CC} | ≤2 ns | V _{CC} /2 | 2×V _{CC} | 50 pF | 500 Ω | 0.3 V |
| 2.5 V \pm 0.2 V | V _{CC} | ≤2 ns | V _{CC} /2 | 2×V _{CC} | 50 pF | 500 Ω | 0.3 V |
| 3.3 V \pm 0.3 V | V_{CC} | ≤2.5 ns | V _{CC} /2 | 2×V _{CC} | 50 pF | 500 Ω | 0.3 V |
| 5 V \pm 0.5 V | v_{cc} | ≤2.5 ns | V _{CC} /2 | 2×V _{CC} | 50 pF | 500 Ω | 0.3 V |



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_0 = 50 \Omega$.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .
- H. All parameters and waveforms are not applicable to all devices.

Figure 5. Load Circuit and Voltage Waveforms



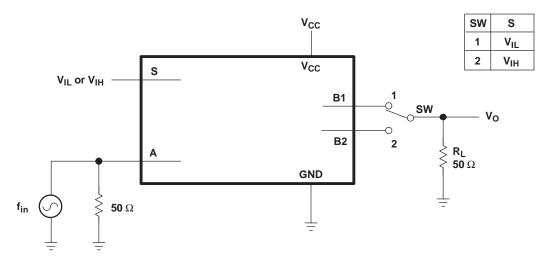


Figure 6. Frequency Response (Switch On)

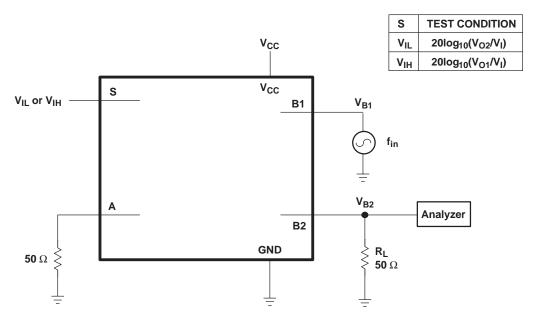


Figure 7. Crosstalk (Between Switches)



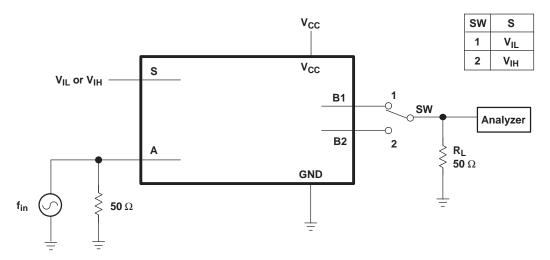


Figure 8. Feedthrough

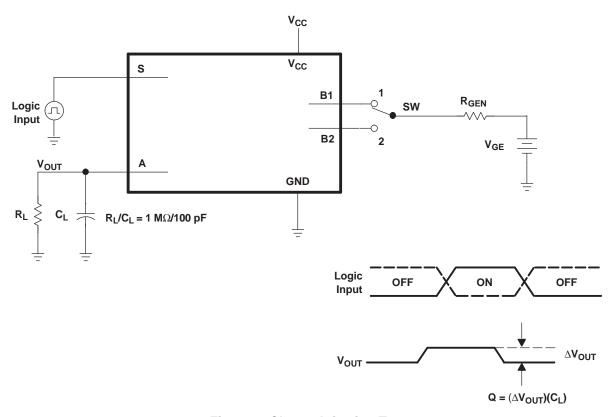


Figure 9. Charge-Injection Test



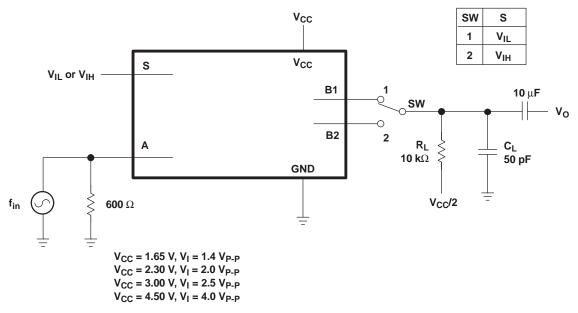


Figure 10. Total Harmonic Distortion

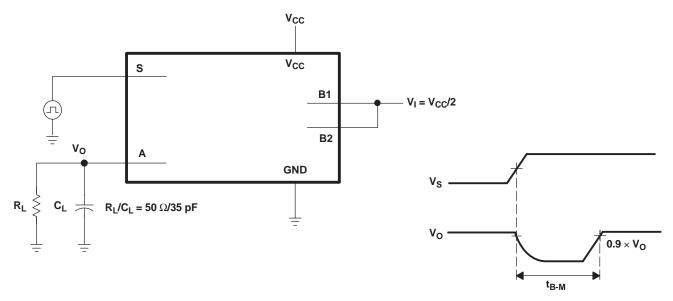


Figure 11. Break-Before-Make Internal Timing

PACKAGE OPTION ADDENDUM

www.ti.com 8-Jul-2009

PACKAGING INFORMATION

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins F | Package Qty | e Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|-----------------|--------------------|--------|----------------|---------------------------|------------------|------------------------------|
| 1P1G3157QDBVRQ1 | ACTIVE | SOT-23 | DBV | 6 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| 1P1G3157QDCKRQ1 | ACTIVE | SC70 | DCK | 6 | 3000 | Green (RoHS & no Sb/Br) | NIPDAU | Level-1-260C-UNLIM |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF SN74LVC1G3157-Q1:

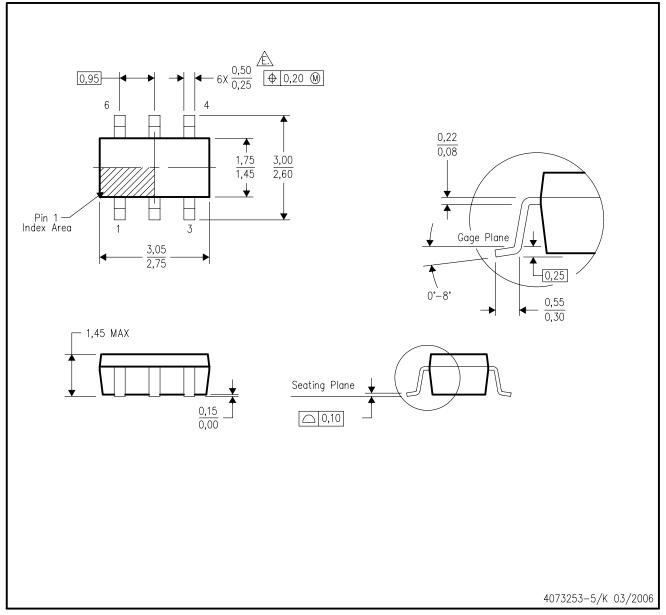
Catalog: SN74LVC1G3157

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

DBV (R-PDSO-G6)

PLASTIC SMALL-OUTLINE PACKAGE



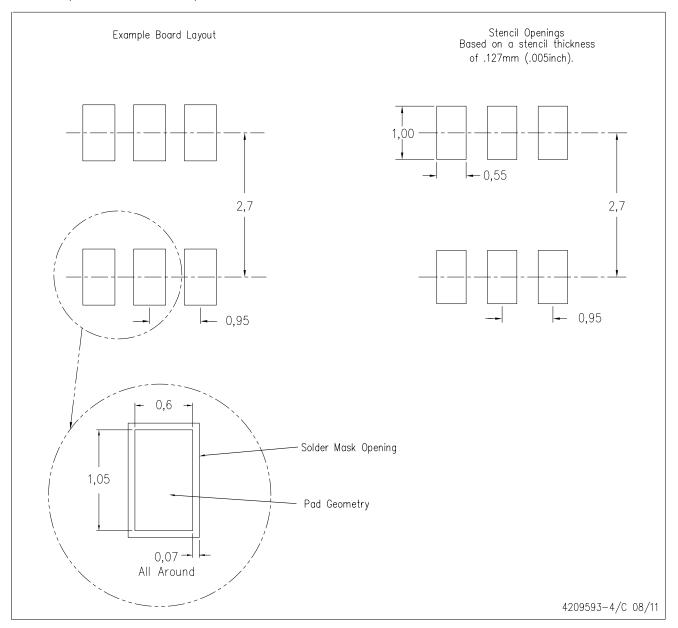
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- Falls within JEDEC MO-178 Variation AB, except minimum lead width.



DBV (R-PDSO-G6)

PLASTIC SMALL OUTLINE



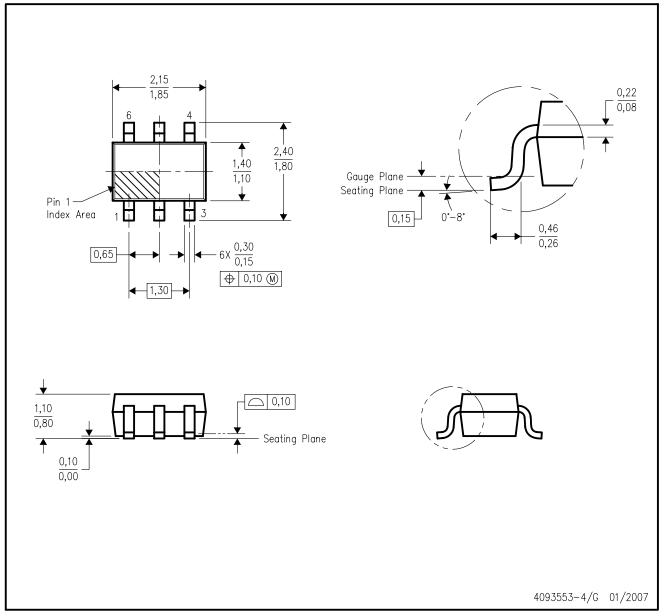
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



DCK (R-PDSO-G6)

PLASTIC SMALL-OUTLINE PACKAGE



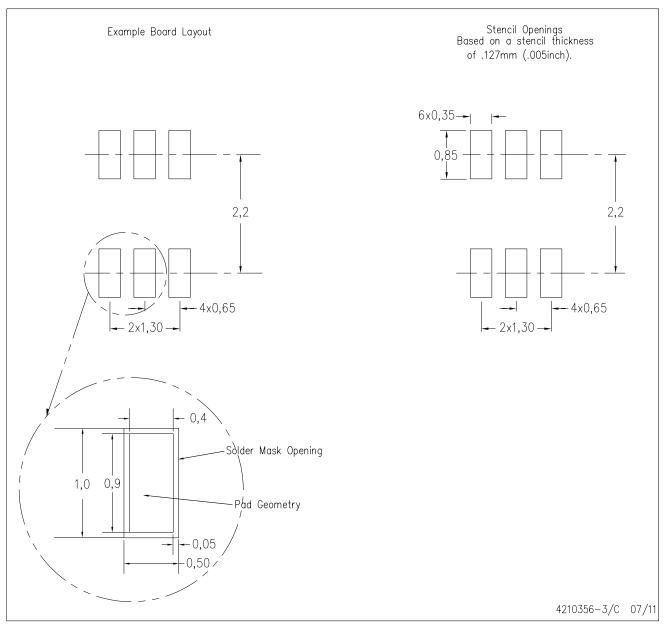
NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-203 variation AB.



DCK (R-PDSO-G6)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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